

<b>Notice of References Cited</b>	Application/Control No. 09/775,986	Applicant(s)/Patent Under Reexamination BLANK ET AL.	
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	C	US-6,618,727	09-2003	Wheeler et al.	707/10
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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